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- Dual Versions of Highly Stable SN54121 and SN74121 One Shots on a Monolithic Chip
- SN54221 and SN74221 Demonstrate **Electrical and Switching Characteristics** That Are Virtually Identical to the SN54121 and SN74121 One Shots
- Pinout Is Identical to the SN54123, SN74123, SN54LS123, SN74LS123
- Overriding Clear Terminates Output Pulse
- Package Options Include Plastic Small-Outline (D) Packages, Ceramic Chip Carriers (FK) and Flat Packs (W), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

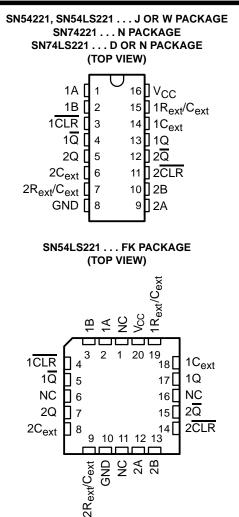
TYPICAL POWER DISSIPATION (mW)	MAXIMUM OUTPUT PULSE LENGTH (s)
130	21
130	28
23	49
23	70
	POWER DISSIPATION (mW) 130 130 23

The '221 and 'LS221 are monolithic dual

multivibrators with performance characteristics virtually identical to those of the '121. Each multivibrator features a negative-transitiontriggered input and a positive-transition-triggered input either of which can be used as an inhibit

description

input.



NC - No internal connection

Pulse triggering occurs at a particular voltage level and is not directly related to the transition time of the input pulse. Schmitt-trigger input circuitry (TTL hysteresis) for B input allows jitter-free triggering from inputs with transition rates as slow as 1 V/s, providing the circuit with excellent noise immunity of typically 1.2 V. A high immunity to V<sub>CC</sub> noise of typically 1.5 V is also provided by internal latching circuitry.

Once fired, the outputs are independent of further transitions of the A and B inputs and are a function of the timing components, or the output pulses can be terminated by the overriding clear. Input pulses can be of any duration relative to the output pulse. Output pulse length can be varied from 35 ns to the maximums shown in the above table by choosing appropriate timing components. With  $R_{ext} = 2 k\Omega$  and  $C_{ext} = 0$ , an output pulse of typically 30 ns is achieved which can be used as a dc-triggered reset signal. Output rise and fall times are TTL compatible and independent of pulse length. Typical triggering and clearing sequences are illustrated as a part of the switching characteristics waveforms.

Pulse-width stability is achieved through internal compensation and is virtually independent of V<sub>CC</sub> and temperature. In most applications, pulse stability is only limited by the accuracy of external timing components.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

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#### description (continued)

Jitter-free operation is maintained over the full temperature and V<sub>CC</sub> ranges for more than six decades of timing capacitance (10 pF to 10  $\mu$ F) and more than one decade of timing resistance (2 k $\Omega$  to 30 k $\Omega$  for the SN54221, 2 k $\Omega$  to 70 k $\Omega$  for the SN54LS221, and 2 k $\Omega$  to 100 k $\Omega$  for the SN74LS221). Throughout these ranges, pulse width is defined by the relationship: t<sub>w</sub>(out) = C<sub>ext</sub>R<sub>ext</sub> *In2*  $\approx$  0.7 C<sub>ext</sub>R<sub>ext</sub>. In circuits where pulse cutoff is not critical, timing capacitance up to 1000  $\mu$ F and timing resistance as low as 1.4 k $\Omega$  can be used. Also, the range of jitter-free output pulse widths is extended if V<sub>CC</sub> is held to 5 V and free-air temperature is 25°C. Duty cycles as high as 90% are achieved when using maximum recommended R<sub>T</sub>. Higher duty cycles are available if a certain amount of pulse-width jitter is allowed.

The variance in output pulse width from device to device is typically less than  $\pm 0.5\%$  for given external timing components. An example of this distribution for the '221 is shown in Figure 2. Variations in output pulse width versus supply voltage and temperature for the '221 are shown in Figures 3 and 4, respectively.

Pin assignments for these devices are identical to those of the SN54123/SN74123 or SN54LS123/SN74LS123 so that the '221 or 'LS221 can be substituted for those products in systems not using the retrigger by merely changing the value of R<sub>ext</sub> and/or C<sub>ext</sub>; however, the polarity of the capacitor will have to be changed.

The SN54221 and SN54LS221 are characterized for operation over the full military temperature range of –55°C to 125°C. The SN74221 and SN74LS221 are characterized for operation from 0°C to 70°C.

	INPUTS		OUTPUTS								
CLR	Α	В	Q	Q							
L	Х	Х	L	Н							
х	Н	х	L	Н							
х	Х	L	L	Н							
н	L	$\uparrow$	ூ ‡	ப‡							
н	$\downarrow$	н	ூ ‡	ப‡							
^†	L	Н	ூ ‡	ப‡							

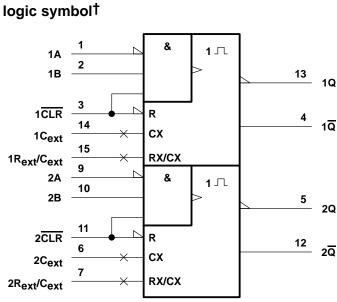
FUNCTION TABLE (each monostable multivibrator)

<sup>†</sup> This condition is true only if the output of the latch formed by the two NAND gates has been conditioned to the logic 1 state prior to CLR going high. This latch is conditioned by taking either A high or B low while CLR is inactive (high).

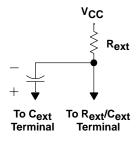
<sup>‡</sup> Pulsed-output patterns are tested during AC switching at 25°C with  $R_{ext} = 2 k\Omega$ , and  $C_{ext} = 80 \text{ pF}.$ 



#### SN54221, SN54LS221, SN74221, SN74LS221 **DUAL MONOSTABLE MULTIVIBRATORS** WITH SCHMITT-TRIGGER INPUTS SDLS213 - DECEMBER 1983 - REVISED MAY 1994



## timing component connections



NOTE: Due to the internal circuit, the  $R_{ext}/C_{ext}$  terminal will never be more positive than the  $C_{ext}$  terminal.

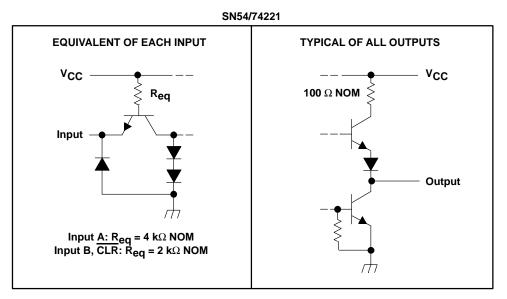
<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for the D, J, N, and W packages.

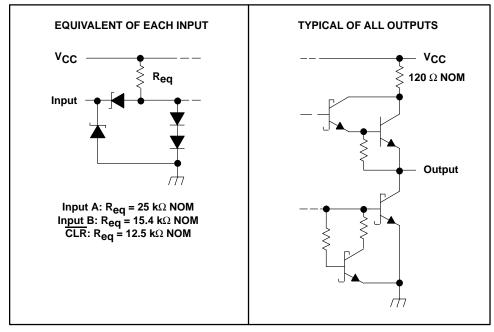


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### schematics of inputs and outputs



SN54/74LS221





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#### recommended operating conditions

			5	SN54221		SN74221		UNIT	
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC	Supply voltage		4.5	5	5.5	4.75	5	5.25	V
VIH	High-level input voltage at A		2			2			V
VIL	Low-level input voltage at A				0.8			0.8	V
IOH	High-level output current				- 800			- 800	μA
IOL	Low-level output current				16			16	mA
Δv/Δt	Diag or fall of input pulse rate	Schmitt-input B	1			1			V/s
$\Delta V / \Delta l$	Rise or fall of input pulse rate	Logic-input A	1			1			V/µs
TA	Operating free-air temperature		-55		125	0		70	°C

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

				:	SN54221			SN74221		UNIT
	PARAMETER	TEST	CONDITIONS	MIN	typ‡	MAX	MIN	TYP‡	MAX	UNIT
V <sub>T+</sub>	Positive going threshold voltage at B	V <sub>CC</sub> = MIN			1.55	2		1.55	2	V
V <sub>T</sub> -	Negative going threshold voltage at B	V <sub>CC</sub> = MIN		0.8	1.35		0.8	1.35		V
VIK		V <sub>CC</sub> = MIN,	l <sub>l</sub> = –12 mA			-1.5			-1.5	V
VOH		V <sub>CC</sub> = MIN,	I <sub>OH</sub> = – 800 μA	2.4	3.4		2.4	3.4		V
VOL		$V_{CC} = MIN,$	I <sub>OL</sub> = 16 mA		0.2	0.4		0.2	0.4	V
Ц		V <sub>CC</sub> = MAX,	V <sub>I</sub> = 5.5 V			1			1	mA
	Input A			40			40	A		
ЧΗ	Input B, CLR	$V_{CC} = MAX,$	V <sub>1</sub> = 2.4 V			80			80	μA
	Input A					-1.6			-1.6	mA
۱L	Input B, CLR	V <sub>CC</sub> = MAX,	V <sub>I</sub> = 0.4 V			-3.2			-3.2	ША
los§		V <sub>CC</sub> = MAX		-20		-55	-18		-55	mA
	Quiescent				26	50		26	50	4
lcc	Triggered	V <sub>CC</sub> = MAX			46	80		46	80	mA

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

<sup>‡</sup>All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> =  $25^{\circ}$ C.

§ Not more than one output should be shorted at a time and the duration of the short circuit should not exceed one second.



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## timing requirements over recommended ranges of supply voltage and operating free-air temperature

			SN54	1221	50 20 15	UNIT		
			MIN	MAX	MIN	MAX	UNIT	
+		A or B, t <sub>w(in)</sub>	50		50			
tw		CLR, t <sub>w(clear)</sub>	20		20		ns	
t <sub>su</sub>	Inactive-state setup time <sup>†</sup>	CLR	15		15		ns	
R <sub>ext</sub>	External timing resistance		1.4	30	1.4	40	kΩ	
C <sub>ext</sub>	External timing capacitance		0	1000	0	1000	μF	
	Output duty cycle	$R_{ext} = 2 k\Omega$		67%		67%		
		R <sub>ext</sub> = MAX R <sub>ext</sub>		90%		90%		

<sup>†</sup> Inactive-state setup time is also referred to as recovery time.

## switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS		TEST CONDITIONS		$V_{CC} = 5 V,$ $C_{L} = 15 \text{ pF},$ $R_{L} = 400 \Omega,$ $T_{A} = 25^{\circ}\text{C}$ SN54221, SN74221			UNIT	
					MIN	TYP	MAX				
t=	A	Q	C <sub>ext</sub> = 80 pF,	0 00 - 5			45	70	ns		
PLH	<sup>t</sup> PLH B	C Cext	$C_{ext} = 80 \text{ pr},$	$R_{ext} = 2 K\Omega_2$		35	55	115			
	A	Q		o oo -	0 00 - 5	0 00 - 5			50	80	
<sup>t</sup> PHL	В	Q	C <sub>ext</sub> = 80 pF,	$R_{ext} = 2 K\Omega$		40	65	ns			
<sup>t</sup> PHL	CLR	Q	C <sub>ext</sub> = 80 pF,	$R_{ext} = 2 k\Omega$			27	ns			
<sup>t</sup> PLH	CLR	Q	C <sub>ext</sub> = 80 pF,	$R_{ext} = 2 k\Omega$			40	ns			
			C <sub>ext</sub> = 80 pF,	$R_{ext} = 2 k\Omega$	70	110	150				
	A or B	Q or $\overline{Q}$	$C_{ext} = 0,$	$R_{ext} = 2 k\Omega$	17	30	50	ns			
t <sub>w</sub>			C <sub>ext</sub> = 100 pF,	$R_{ext} = 10 \ k\Omega$	650	700	750				
			$C_{ext} = 1 \ \mu F$ ,	$R_{ext}$ = 10 k $\Omega$	6.5	7	7.5	ms			



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#### recommended operating conditions

			SI	N54LS22	21	SN74LS221		UNIT	
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC	Supply voltage		4.5	5	5.5	4.75	5	5.25	V
VIH	High-level input voltage at A		2			2			V
VIL	Low-level input voltage at A				0.7			0.8	V
ЮН	High-level output current				- 400			- 400	μA
IOL	Low-level output current				4			8	mA
Δv/Δt		Schmitt-input B	1			1			V/s
Δν/Δι	Rise or fall of input pulse rate Logic-input A	Logic-input A	1			1			V/µs
TA	Operating free-air temperature		-55		125	0		70	°C

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	DADAMETED	TEOT		S	N54LS22	1	SI	N74LS22	:1	UNIT
	PARAMETER	IESIC	CONDITIONS	MIN	TYP‡	MAX	MIN	TYP‡	2 MAX 2 -1.5 0.4 0.5 0.1 20 -0.4 -0.8 -100 11	UNIT
V <sub>T+</sub>	Positive going threshold voltage at B	V <sub>CC</sub> = MIN			1	2		1	2	V
V <sub>T</sub> –	Negative going threshold voltage at B	V <sub>CC</sub> = MIN		0.7	0.9		0.8	0.9		V
VIK		V <sub>CC</sub> = MIN,	I <sub>I</sub> = -18 mA			-1.5			-1.5	V
VOH		V <sub>CC</sub> = MIN,	I <sub>OH</sub> = – 400 μA	2.5	3.4		2.7	3.4		V
Vai			I <sub>OL</sub> = 4 mA		0.25	0.4		0.25	0.4	v
VOL		V <sub>CC</sub> = MIN	I <sub>OL</sub> = 8 mA					0.35	0.5	v
ц		V <sub>CC</sub> = MAX,	V <sub>I</sub> = 7 V			0.1			0.1	mA
Iн		V <sub>CC</sub> = MAX,	V <sub>I</sub> = 2.7 V			20			20	μΑ
	Input A					-0.4			-0.4	
ΊL	Input B, CLR	V <sub>CC</sub> = MAX,	V <sub>I</sub> = 0.4 V			-0.8			-0.8	mA
los§		V <sub>CC</sub> = MAX		-20		-100	-20		-100	mA
	Quiescent				4.7	11		4.7	11	
lcc	Triggered	V <sub>CC</sub> = MAX			19	27		19	27	mA

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions. <sup>‡</sup> All typical values are at  $V_{CC}$  = 5 V,  $T_A$  = 25°C. § Not more than one output should be shorted at a time and the duration of the short circuit should not exceed one second.



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## timing requirements over recommended ranges of supply voltage and operating free-air temperature

			SN54L	.S221	50 40 15	UNIT		
			MIN	MAX	MIN	MAX	UNIT	
		A or B, t <sub>w(in)</sub>	50		50			
tw		CLR, tw(clear)	40		40		ns	
t <sub>su</sub>	Inactive-state setup time <sup>†</sup>	CLR	15		15		ns	
R <sub>ext</sub>	External timing resistance		1.4	70	1.4	100	kΩ	
C <sub>ext</sub>	External timing capacitance		0	1000	0	1000	μF	
	Output duty cycle	$R_{T} = 2 k\Omega$		50%		50%		
		$R_T = MAX R_{ext}$		90%		90%		

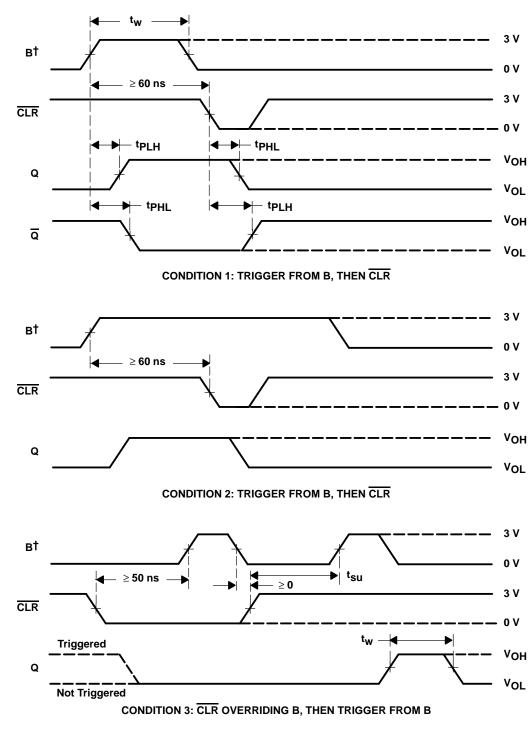
<sup>†</sup> Inactive-state setup time is also referred to as recovery time.

## switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS		CL RL TA SN	C = 5 V = 15 pl = 2 kΩ = 25°C 54LS22	; ' 1	UNIT		
					MIN	TYP	MAX			
touu	А	Q	C <sub>ext</sub> = 80 pF,	C			45	70	ns	
<sup>t</sup> PLH	В	Q	$C_{ext} = 80 \text{ pr},$	Rext = 2 K32		35	55	115		
	A	IQ	o oo -	0 00 - 5	0 00 - 5			50	80	
<sup>t</sup> PHL	В	Q	C <sub>ext</sub> = 80 pF,	$R_{ext} = 2 K\Omega$		40	65	ns		
<sup>t</sup> PHL	CLR	Q	C <sub>ext</sub> = 80 pF,	$R_{ext} = 2 k\Omega$		35	55	ns		
<sup>t</sup> PLH	CLR	Q	C <sub>ext</sub> = 80 pF,	$R_{ext} = 2 k\Omega$		44	65	ns		
			C <sub>ext</sub> = 80 pF,	$R_{ext} = 2 k\Omega$	70	120	150			
	A or B	Q or $\overline{Q}$	$C_{ext} = 0,$	$R_{ext} = 2 k\Omega$	20	47	70	ns		
t <sub>w</sub>	AUID		C <sub>ext</sub> = 100 pF,	$R_{ext} = 10 k\Omega$	670	740	810			
			$C_{ext} = 1 \ \mu F$ ,	R <sub>ext</sub> = 10 kΩ	6	6.9	7.5	ms		



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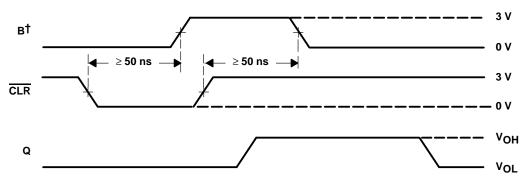
<sup>†</sup> A is low.



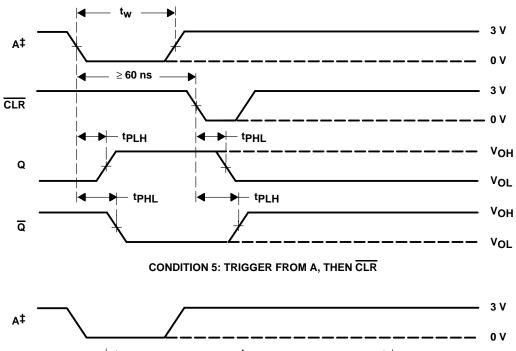


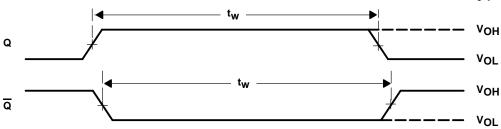
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### PARAMETER MEASUREMENT INFORMATION



CONDITION 4: TRIGGERING FROM POSITIVE TRANSITION OF CLR





#### **CONDITION 6: TRIGGER FROM A**

† A is low.

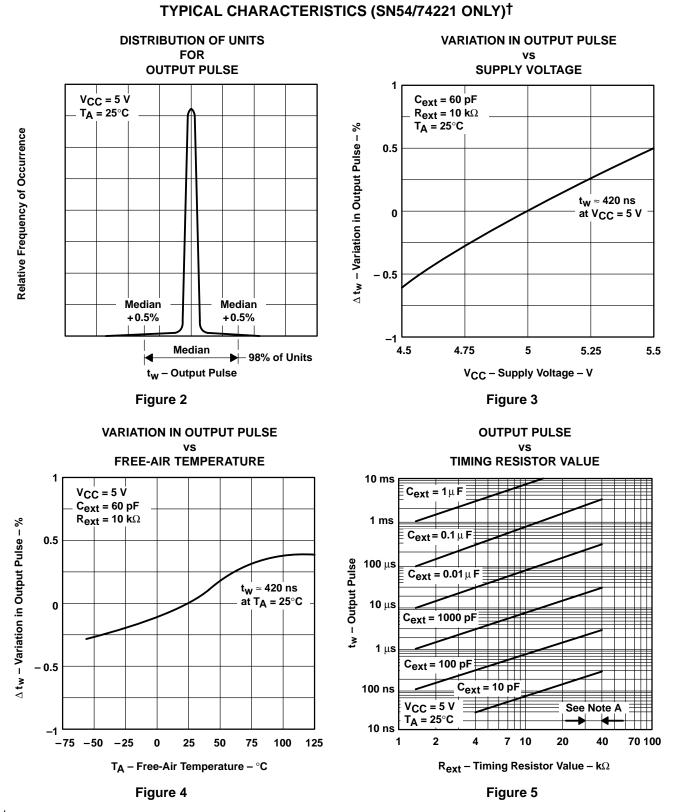
 $\ddagger$  B and  $\overline{\text{CLR}}$  are high.

- NOTES: A. Input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz, Z<sub>O</sub>  $\approx$  50 $\Omega$ ; for SN54/74221, t<sub>f</sub>  $\leq$  7 ns, t<sub>f</sub>  $\leq$  7 ns, for SN54/74LS221, t<sub>f</sub>  $\leq$  6 ns.
  - B. All measurements are made between the 1.5-V points of the indicated transitions for the SN54/74221 or between the 1.3-V points for the SN54/74LS221.





SN54221, SN54LS221, SN74221, SN74LS221 DUAL MONOSTABLE MULTIVIBRATORS WITH SCHMITT-TRIGGER INPUTS SDLS213 – DECEMBER 1983 – REVISED MAY 1994



<sup>†</sup> Data for temperatures below 0°C and above 70°C, and for supply voltages below 4.75 V and above 5.25 V are applicable for the SN54221 only. NOTE A: These values of resistance exceed the maximum recommended for use over the full temperature range of the SN54221.



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